## Notice of References Cited Application/Control No. 10/720,132 Examiner Jerrold Johnson Applicant(s)/Patent Under Reexamination CHEN ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2004/0069732	04-2004	Huang et al.	211/183
	В	US-6,036,031	03-2000	Ishikawa, Toshio	211/41.18
	С	US-3,877,134	04-1975	Shanahan, Thomas W.	29/417
	D	US-5,638,958	06-1997	Sanchez, Jose L.	206/710
	Ε	US-4,930,634	06-1990	Williams et al.	206/454
	F	US-D292,743	11-1987	Hung, Patrick	D3/315
	G	US-4,600,231	07-1986	Sickles, Willard J.	294/161
	Н	US-4,153,164	05-1979	Hofmeister et al.	211/41.18
	ı	US-3,682,083	08-1972	Puente, Jose R.	396/654
	J	US-6,430,046	08-2002	Komatsu, Kazuo	361/690
	К	US-3,877,134	04-1975	Shanahan, Thomas W.	29/417
	L	US-			
	М	US-			

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	α					
	R					
	S					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	,
	v	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYYY format are publication dates. Classifications may be US or foreign.